

December 2011

FDMS86500DC

N-Channel Dual CoolTM Power Trench[®] MOSFET 60 V, 60 A, 2.3 m Ω

Features

- Dual CoolTM Top Side Cooling PQFN package
- Max $r_{DS(on)}$ = 2.3 m Ω at V_{GS} = 10 V, I_D = 29 A
- Max $r_{DS(on)} = 3.3 \text{ m}\Omega$ at $V_{GS} = 8 \text{ V}$, $I_D = 24 \text{ A}$
- High performance technology for extremely low r_{DS(on)}
- 100% UIL Tested
- RoHS Compliant

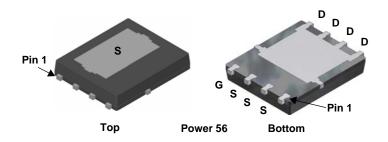


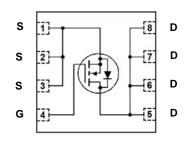
General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process. Advancements in both silicon and Dual CoolTM package technologies have been combined to offer the lowest r_{DS(on)} while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

Applications

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation Vcore Low Side





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Parameter | | | Ratings | Units |
|-----------------------------------|--|------------------------|-----------|-------------|-------|
| V _{DS} | Drain to Source Voltage | | | 60 | V |
| V _{GS} | Gate to Source Voltage | | | ±20 | V |
| | Drain Current -Continuous (Package limited) | T _C = 25 °C | | 60 | |
| | -Continuous (Silicon limited) | T _C = 25 °C | | 177 | Δ. |
| ID | -Continuous | T _A = 25 °C | (Note 1a) | 29 | Α |
| | -Pulsed | | | 200 | |
| E _{AS} | Single Pulse Avalanche Energy | | (Note 3) | 317 | mJ |
| D | Power Dissipation | T _C = 25 °C | | 125 | W |
| P_D | Power Dissipation | T _A = 25 °C | (Note 1a) | 3.2 | VV |
| T _J , T _{STG} | Operating and Storage Junction Temperature R | ange | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | (Top Source) | 2.8 | |
|-----------------|---|----------------|-----|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | (Bottom Drain) | 1.0 | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 38 | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1b) | 81 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1i) | 16 | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1j) | 23 | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1k) | 11 | |

Package Marking and Ordering Information

| 96500 EDMS96500DC Dual Cool TM Boylor 56 13" 12 mm 20 | | | | | |
|--|------------|-------------------|------------------------------|----------|--------------|
| 86500 FDMS86500DC Dual Cool ···· Power 56 13 12 mm 30 | 86500 FDMS | S86500DC Dual Cod | ol TM Power 56 13 | 3" 12 mm | n 3000 units |

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|--|--|---|-----|-----|------|-------|
| Off Chara | acteristics | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 60 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250 \mu A$, referenced to 25°C | | 30 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 48 V, V _{GS} = 0 V | | | 1 | μΑ |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±100 | nA |

On Characteristics

| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_{D} = 250 \mu A$ | 2.5 | 3.7 | 4.5 | V |
|--|--|---|-----|-----|-----|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I_D = 250 μ A, referenced to 25 °C | | -12 | | mV/°C |
| | | $V_{GS} = 10 \text{ V}, I_D = 29 \text{ A}$ | | 1.9 | 2.3 | |
| r _{DS(on)} | r _{DS(on)} Static Drain to Source On Resistance | $V_{GS} = 8 \text{ V}, I_D = 24 \text{ A}$ | | 2.4 | 3.3 | mΩ |
| | | $V_{GS} = 10 \text{ V}, I_D = 29 \text{ A}, T_J = 125 ^{\circ}\text{C}$ | | 3.0 | 3.7 | |
| 9 _{FS} | Forward Transconductance | V _{DS} = 10 V, I _D = 29 A | | 98 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V 20 V V 0 V | 5775 | 7680 | pF |
|------------------|------------------------------|--|------|------|----|
| Coss | Output Capacitance | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$ | 1605 | 2680 | рF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 1 10112 | 48 | 95 | pF |
| R_g | Gate Resistance | | 1.0 | | Ω |

Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | | 35 | 56 | ns |
|---------------------|-------------------------------|---|-----|-----|----|
| t _r | Rise Time | $V_{DD} = 30 \text{ V}, I_{D} = 29 \text{ A},$ | 25 | 40 | ns |
| t _{d(off)} | Turn-Off Delay Time | $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | 34 | 54 | ns |
| t _f | Fall Time | | 8.2 | 17 | ns |
| 0 | Total Gate Charge | V _{GS} = 0 V to 10 V | 76 | 107 | nC |
| $Q_{g(TOT)}$ | Total Gate Charge | $V_{GS} = 0 \text{ V to 8 V}$ $V_{DD} = 30 \text{ V}$ | 62 | 87 | nC |
| Q_{gs} | Total Gate Charge | I _D = 29 A | 31 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | 15 | | nC |

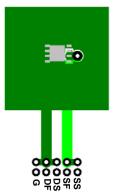
Drain-Source Diode Characteristics

| V _{SD} Source to Drain Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = 2.7 \text{ A}$ (Note 2) | | 0.71 | 1.2 | \/ | |
|---|--|---|------|------|-----|----|
| V_{SD} | Source to Drain Diode Porward voltage | $V_{GS} = 0 \text{ V}, I_{S} = 29 \text{ A}$ (Note 2) | | 0.79 | 1.3 | V |
| t _{rr} | Reverse Recovery Time | L = 20 A di/dt = 100 A/us | | 59 | 95 | ns |
| Q _{rr} | Reverse Recovery Charge | I _F = 29 A, di/dt = 100 A/μs | | 46 | 74 | nC |

Thermal Characteristics

| Thermal Resistance, Junction to Case | (Top Source) | 2.8 | |
|---|--|---|---|
| Thermal Resistance, Junction to Case | (Bottom Drain) | 1.0 | |
| Thermal Resistance, Junction to Ambient | (Note 1a) | 38 | |
| Thermal Resistance, Junction to Ambient | (Note 1b) | 81 | |
| Thermal Resistance, Junction to Ambient | (Note 1c) | 27 | |
| Thermal Resistance, Junction to Ambient | (Note 1d) | 34 | |
| Thermal Resistance, Junction to Ambient | (Note 1e) | 16 | 0000 |
| Thermal Resistance, Junction to Ambient | (Note 1f) | 19 | °C/W |
| Thermal Resistance, Junction to Ambient | (Note 1g) | 26 | |
| Thermal Resistance, Junction to Ambient | (Note 1h) | 61 | |
| Thermal Resistance, Junction to Ambient | (Note 1i) | 16 | |
| Thermal Resistance, Junction to Ambient | (Note 1j) | 23 | |
| Thermal Resistance, Junction to Ambient | (Note 1k) | 11 | |
| Thermal Resistance, Junction to Ambient | (Note 1I) | 13 | |
| | Thermal Resistance, Junction to Case Thermal Resistance, Junction to Ambient | Thermal Resistance, Junction to Case (Bottom Drain) Thermal Resistance, Junction to Ambient (Note 1a) Thermal Resistance, Junction to Ambient (Note 1b) Thermal Resistance, Junction to Ambient (Note 1c) Thermal Resistance, Junction to Ambient (Note 1d) Thermal Resistance, Junction to Ambient (Note 1e) Thermal Resistance, Junction to Ambient (Note 1f) Thermal Resistance, Junction to Ambient (Note 1g) Thermal Resistance, Junction to Ambient (Note 1h) Thermal Resistance, Junction to Ambient (Note 1i) Thermal Resistance, Junction to Ambient (Note 1j) Thermal Resistance, Junction to Ambient (Note 1j) Thermal Resistance, Junction to Ambient (Note 1k) | Thermal Resistance, Junction to Case (Bottom Drain) 1.0 Thermal Resistance, Junction to Ambient (Note 1a) 38 Thermal Resistance, Junction to Ambient (Note 1b) 81 Thermal Resistance, Junction to Ambient (Note 1c) 27 Thermal Resistance, Junction to Ambient (Note 1d) 34 Thermal Resistance, Junction to Ambient (Note 1d) 34 Thermal Resistance, Junction to Ambient (Note 1e) 16 Thermal Resistance, Junction to Ambient (Note 1f) 19 Thermal Resistance, Junction to Ambient (Note 1g) 26 Thermal Resistance, Junction to Ambient (Note 1h) 61 Thermal Resistance, Junction to Ambient (Note 1i) 16 Thermal Resistance, Junction to Ambient (Note 1j) 23 Thermal Resistance, Junction to Ambient (Note 1k) 11 |

^{1.} R_{0JA} is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 38 °C/W when mounted on a 1 in2 pad of 2 oz copper



b. 81 °C/W when mounted on a minimum pad of 2 oz copper

- c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in 2 pad of 2 oz copper
- d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g. 200FPM Airflow, No Heat Sink,1 in² pad of 2 oz copper
- h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in² pad of 2 oz copper
- j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. Starting T $_{J}$ = 25 °C; N-ch: L = 0.3 mH, I $_{AS}$ = 46 A, V $_{DD}$ = 54 V, V $_{GS}$ = 10 V.

Typical Characteristics T_J = 25 °C unless otherwise noted

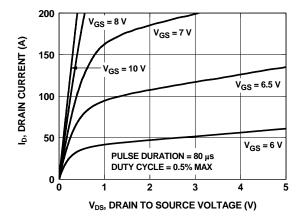


Figure 1. On-Region Characteristics

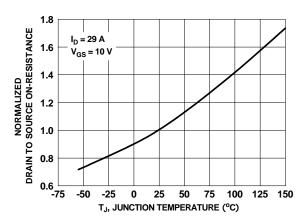


Figure 3. Normalized On-Resistance vs Junction Temperature

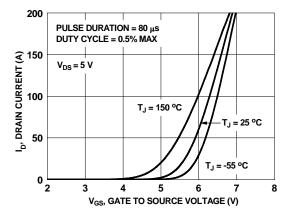


Figure 5. Transfer Characteristics

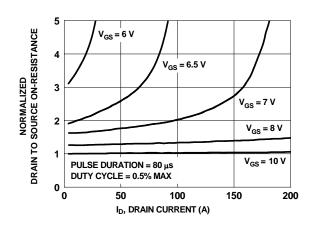


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

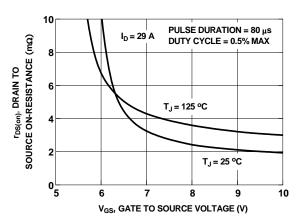


Figure 4. On-Resistance vs Gate to Source Voltage

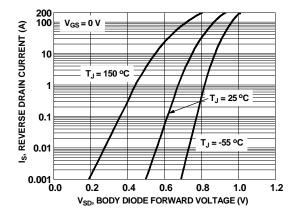


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

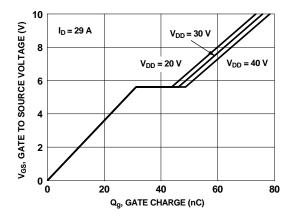


Figure 7. Gate Charge Characteristics

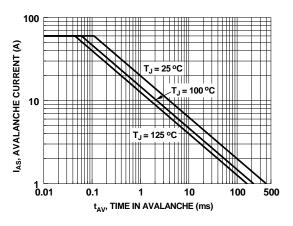


Figure 9. Unclamped Inductive Switching Capability

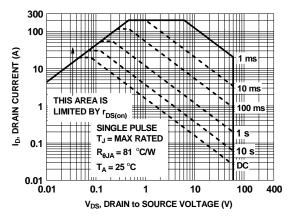


Figure 11. Forward Bias Safe Operating Area

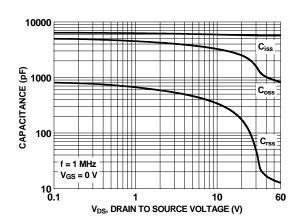


Figure 8. Capacitance vs Drain to Source Voltage

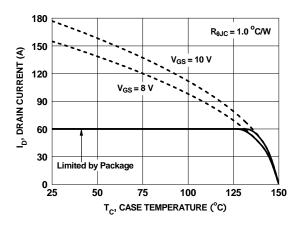


Figure 10. Maximum Continuous Drain Current vs Case Temperature

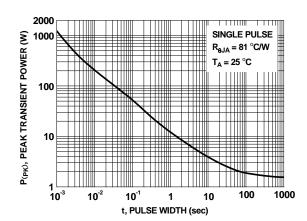


Figure 12. Single Pulse Maximum Power Dissipation



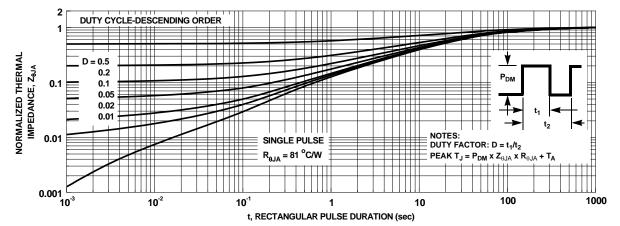
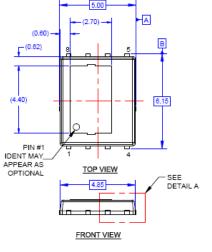
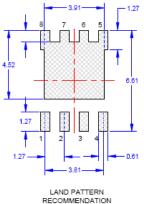
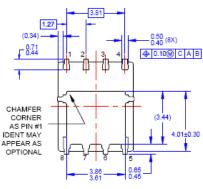


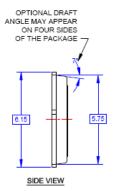
Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout

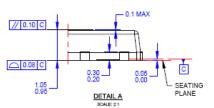












NOTES: UNLESS OTHERWISE SPECIFIED

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 JEDEC MC-240, IGDUE A, VAR. AA,
 DATED GOTOSER 2002.

 B) ALL DIMENSIONS ARE IN MILLIMETERS.
 O) DIMENSIONS DO NOT INCLUDE BURSO
 OR MOLD FLASH. MOLD FLASH OR
 BURSO DOES NOT EXCESS 0.16MM.
 D) DIMENSIONINS AND TOLERANCINS PER
 ADME Y14 SM-1934.
 E) DRAWING FILE NAME: POFNOSDREV1





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